



September 2013

# FGB40N60SM

## 600 V, 40 A Field Stop IGBT

### Features

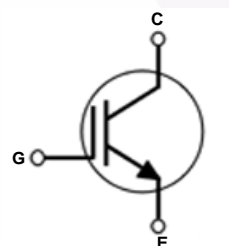
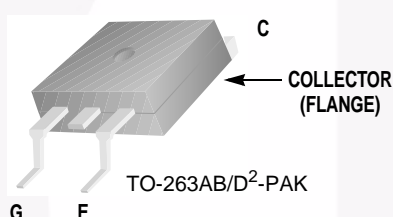
- Maximum Junction Temperature :  $T_J = 175^{\circ}\text{C}$
- Positive Temperature Co-efficient for Easy Parallel Operating
- High Current Capability
- Low Saturation Voltage:  $V_{CE(sat)} = 1.9\text{ V(Typ.)}$  @  $I_C = 40\text{ A}$
- High Input Impedance
- Fast Switching
- Tighten Parameter Distribution
- RoHS Compliant
- IR Reflow Only

### Applications

- Welder, PFC

### General Description

Using novel field stop IGBT technology, Fairchild's new series of field stop 2<sup>nd</sup> generation IGBTs offer the optimum performance for welder and PFC applications where low conduction and switching losses are essential.



### Absolute Maximum Ratings

| Symbol      | Description   | Ratings     | Unit               |
|-------------|---|-------------|--------------------|
| $V_{CES}$   | Collector to Emitter Voltage  | 600         | V                  |
| $V_{GES}$   | Gate to Emitter Voltage   | $\pm 20$    | V                  |
|             | Transient Gate to Emitter Voltage                                       | $\pm 30$    | V                  |
| $I_C$       | Collector Current @ $T_C = 25^{\circ}\text{C}$                          | 80          | A                  |
|             | Collector Current @ $T_C = 100^{\circ}\text{C}$                         | 40          | A                  |
| $I_{CM(1)}$ | Pulsed Collector Current  | 120         | A                  |
| $P_D$       | Maximum Power Dissipation @ $T_C = 25^{\circ}\text{C}$                  | 349         | W                  |
|             | Maximum Power Dissipation @ $T_C = 100^{\circ}\text{C}$                 | 174         | W                  |
| $T_J$       | Operating Junction Temperature  | -55 to +175 | $^{\circ}\text{C}$ |
| $T_{stg}$   | Storage Temperature Range   | -55 to +175 | $^{\circ}\text{C}$ |
| $T_L$       | Maximum Lead Temp. for soldering Purposes, 1/8" from case for 5 seconds | 300         | $^{\circ}\text{C}$ |

#### Notes:

1: Repetitive rating: Pulse width limited by max. junction temperature

## Thermal Characteristics

| Symbol                 | Parameter                               | Typ. | Max. | Unit                        |
|------------------------|---|------|------|-----------------------------|
| $R_{\theta JC}$ (IGBT) | Thermal Resistance, Junction to Case    | -    | 0.43 | $^{\circ}\text{C}/\text{W}$ |
| $R_{\theta JA}$        | Thermal Resistance, Junction to Ambient | -    | 62.5 | $^{\circ}\text{C}/\text{W}$ |

## Package Marking and Ordering Information

| Device Marking | Device     | Package                       | Reel Size | Tape Width | Quantity |
|----------------|------------|-------------------------------|-----------|------------|----------|
| FGB40N60SM     | FGB40N60SM | TO-263AB(D <sup>2</sup> -PAK) | -         | -          | 50       |

## Electrical Characteristics of the IGBT $T_C = 25^{\circ}\text{C}$ unless otherwise noted

| Symbol                               | Parameter                                    | Test Conditions  | Min. | Typ. | Max. | Unit |
|--------------------------------------|--|--|------|------|------|------|
| Off Characteristics                  |  |  |      |      |      |      |
| BV <sub>CES</sub>                    | Collector to Emitter Breakdown Voltage       | V <sub>GE</sub> = 0V, I <sub>C</sub> = 250μA   | 600  | -    | -    | V    |
| $\frac{\Delta BV_{CES}}{\Delta T_J}$ | Temperature Coefficient of Breakdown Voltage | V <sub>GE</sub> = 0V, I <sub>C</sub> = 250μA   | -    | 0.6  | -    | V/°C |
| I <sub>CES</sub>                     | Collector Cut-Off Current                    | V <sub>CE</sub> = V <sub>CES</sub> , V <sub>GE</sub> = 0V  | -    | -    | 250  | μA   |
| I <sub>GES</sub>                     | G-E Leakage Current                          | V <sub>GE</sub> = V <sub>GES</sub> , V <sub>CE</sub> = 0V  | -    | -    | ±400 | nA   |
| On Characteristics                   |  |  |      |      |      |      |
| V <sub>GE(th)</sub>                  | G-E Threshold Voltage                        | I <sub>C</sub> = 250μA, V <sub>CE</sub> = V <sub>GE</sub>  | 3.5  | 4.5  | 6.0  | V    |
| V <sub>CE(sat)</sub>                 | Collector to Emitter Saturation Voltage      | I <sub>C</sub> = 40A, V <sub>GE</sub> = 15V  | -    | 1.9  | 2.3  | V    |
|                                      |  | I <sub>C</sub> = 40A, V <sub>GE</sub> = 15V, T <sub>C</sub> = 175°C  | -    | 2.1  | -    | V    |
| Dynamic Characteristics              |  |  |      |      |      |      |
| C <sub>ies</sub>                     | Input Capacitance                            | V <sub>CE</sub> = 30V, V <sub>GE</sub> = 0V, f = 1MHz  | -    | 1880 | -    | pF   |
| C <sub>oes</sub>                     | Output Capacitance                           |  | -    | 180  | -    | pF   |
| C <sub>res</sub>                     | Reverse Transfer Capacitance                 |  | -    | 50   | -    | pF   |
| Switching Characteristics            |  |  |      |      |      |      |
| t <sub>d(on)</sub>                   | Turn-On Delay Time                           | V <sub>CC</sub> = 400V, I <sub>C</sub> = 40A, R <sub>G</sub> = 6Ω, V <sub>GE</sub> = 15V, Inductive Load, T <sub>C</sub> = 25°C  | -    | 12   | 16   | ns   |
| t <sub>r</sub>                       | Rise Time                                    |  | -    | 20   | 28   | ns   |
| t <sub>d(off)</sub>                  | Turn-Off Delay Time                          |  | -    | 92   | 120  | ns   |
| t <sub>f</sub>                       | Fall Time                                    |  | -    | 13   | 17   | ns   |
| E <sub>on</sub>                      | Turn-On Switching Loss                       |  | -    | 0.87 | 1.30 | mJ   |
| E <sub>off</sub>                     | Turn-Off Switching Loss                      | V <sub>CC</sub> = 400V, I <sub>C</sub> = 40A, R <sub>G</sub> = 6Ω, V <sub>GE</sub> = 15V, Inductive Load, T <sub>C</sub> = 175°C | -    | 0.26 | 0.34 | mJ   |
| E <sub>ts</sub>                      | Total Switching Loss                         |  | -    | 1.13 | 1.64 | mJ   |
| t <sub>d(on)</sub>                   | Turn-On Delay Time                           |  | -    | 15   | -    | ns   |
| t <sub>r</sub>                       | Rise Time                                    |  | -    | 22   | -    | ns   |
| t <sub>d(off)</sub>                  | Turn-Off Delay Time                          |  | -    | 116  | -    | ns   |
| t <sub>f</sub>                       | Fall Time                                    |  | -    | 16   | -    | ns   |
| E <sub>on</sub>                      | Turn-On Switching Loss                       |  | -    | 0.97 | -    | mJ   |
| E <sub>off</sub>                     | Turn-Off Switching Loss                      | -  | 0.60 | -    | mJ   |      |
| E <sub>ts</sub>                      | Total Switching Loss                         | -  | 1.57 | -    | mJ   |      |

**Electrical Characteristics of the IGBT** (Continued)

| Symbol   | Parameter                | Test Conditions                               | Min. | Typ. | Max | Unit |
|----------|--------------------------|---|------|------|-----|------|
| $Q_g$    | Total Gate Charge        | $V_{CE} = 400V, I_C = 40A,$<br>$V_{GE} = 15V$ | -    | 119  | 180 | nC   |
| $Q_{ge}$ | Gate to Emitter Charge   |   | -    | 13   | 20  | nC   |
| $Q_{gc}$ | Gate to Collector Charge |   | -    | 58   | 90  | nC   |



## Typical Performance Characteristics

Figure 1. Typical Output Characteristics

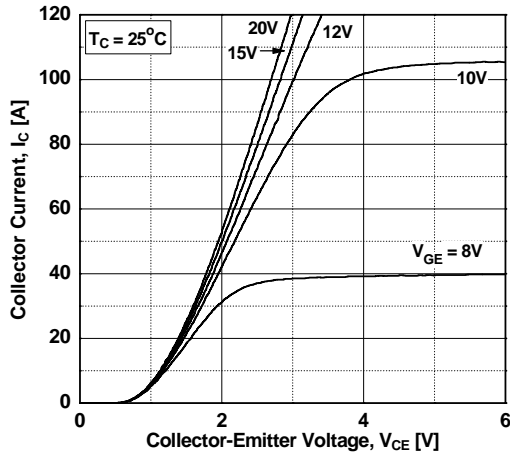


Figure 2. Typical Output Characteristics

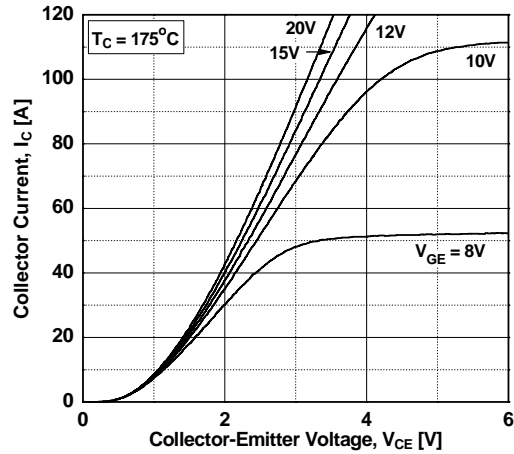


Figure 3. Typical Saturation Voltage Characteristics

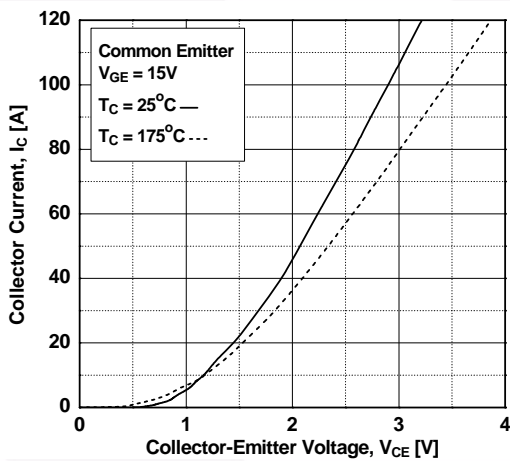


Figure 4. Saturation Voltage vs. Case Temperature at Variant Current Level

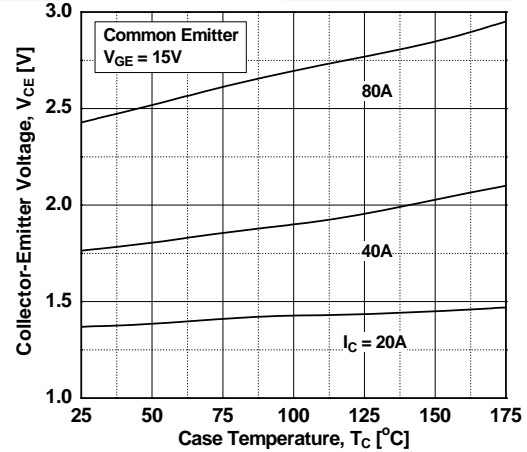


Figure 5. Saturation Voltage vs. Vge

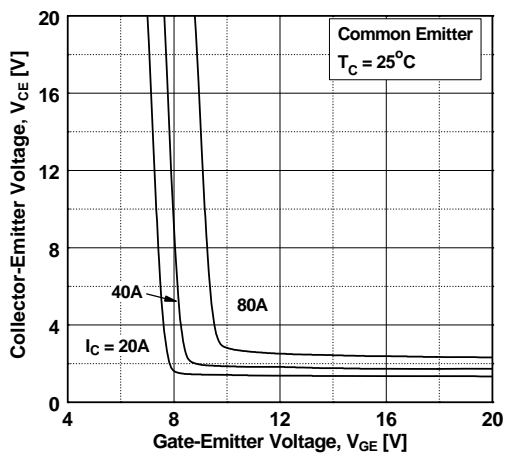
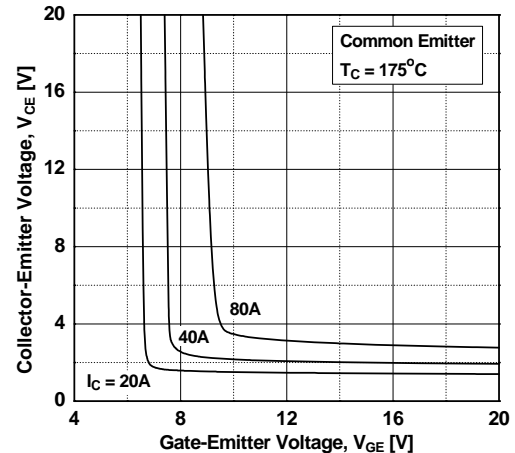


Figure 6. Saturation Voltage vs. Vge



## Typical Performance Characteristics

Figure 7. Capacitance Characteristics

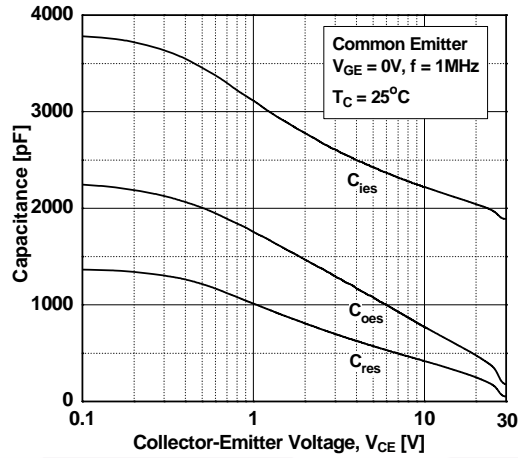


Figure 8. Gate charge Characteristics

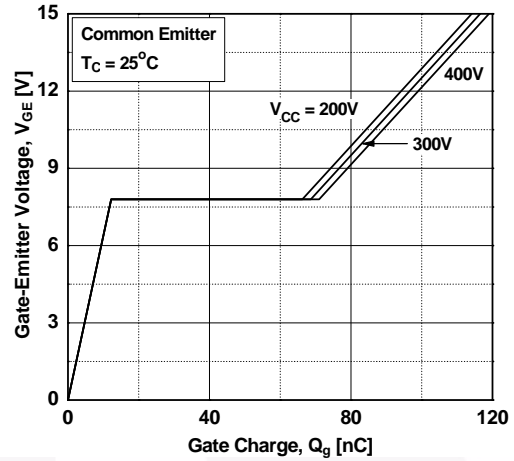


Figure 9. Turn-on Characteristics vs. Gate Resistance

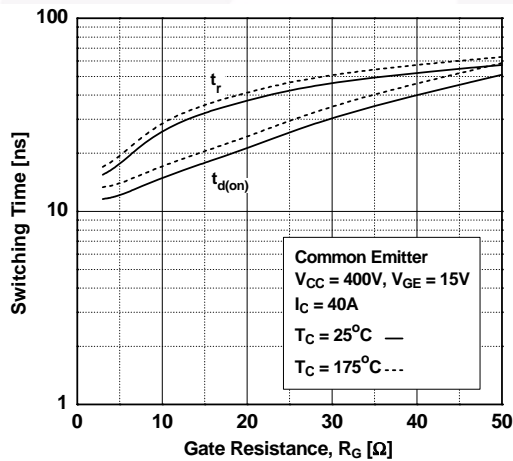


Figure 10. Turn-off Characteristics vs. Gate Resistance

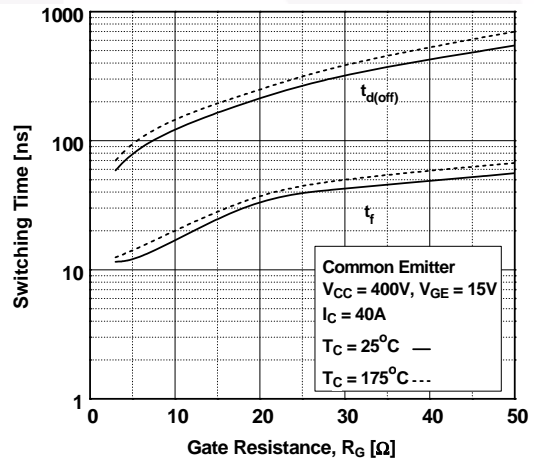


Figure 11. Switching Loss vs. Gate Resistance

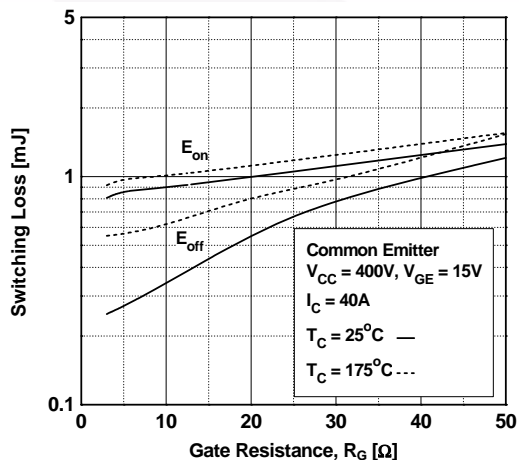
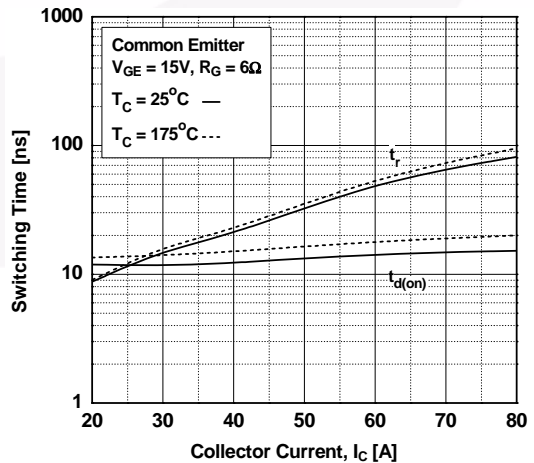


Figure 12. Turn-on Characteristics vs. Collector Current



## Typical Performance Characteristics

Figure 13. Turn-off Characteristics vs. Collector Current

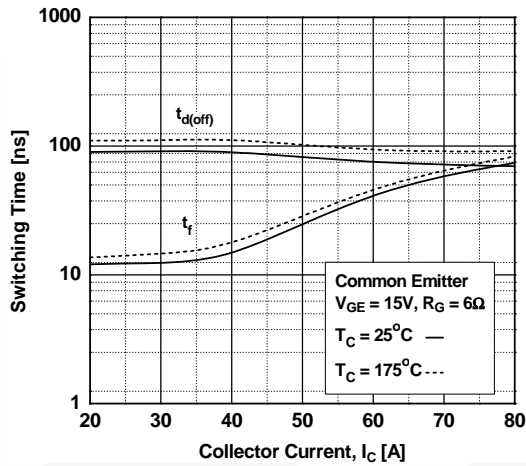


Figure 14. Switching Loss vs. Collector Current

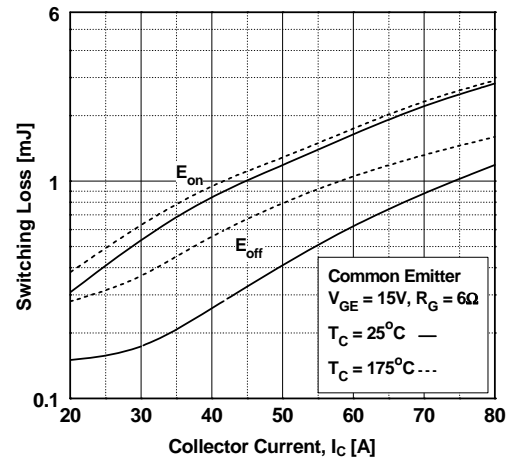


Figure 15. Load Current Vs. Frequency

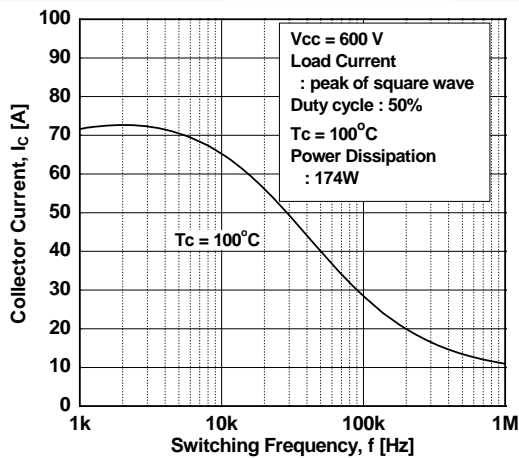


Figure 16. SOA Characteristics

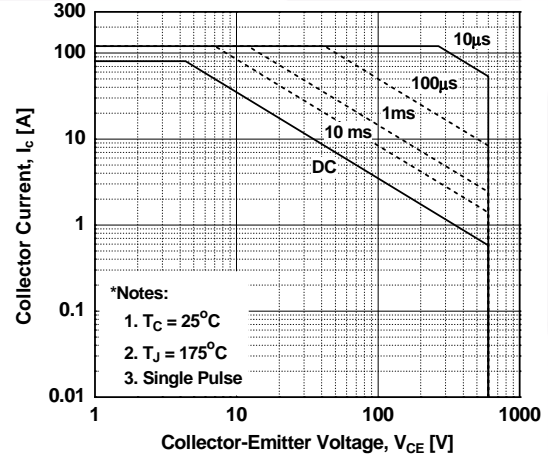
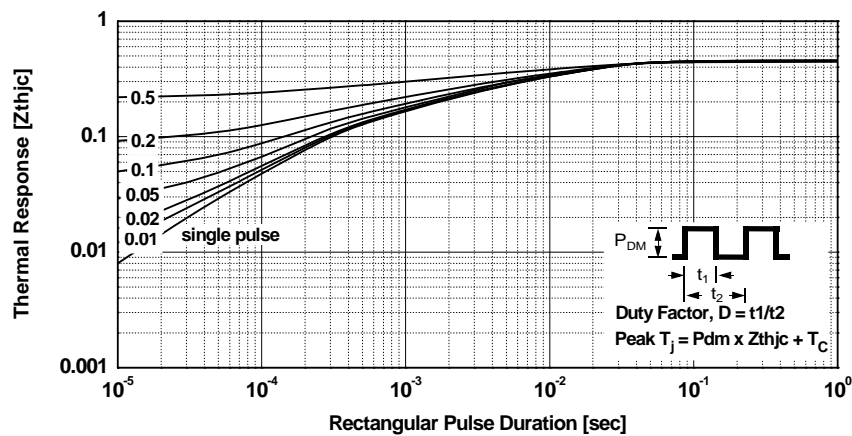
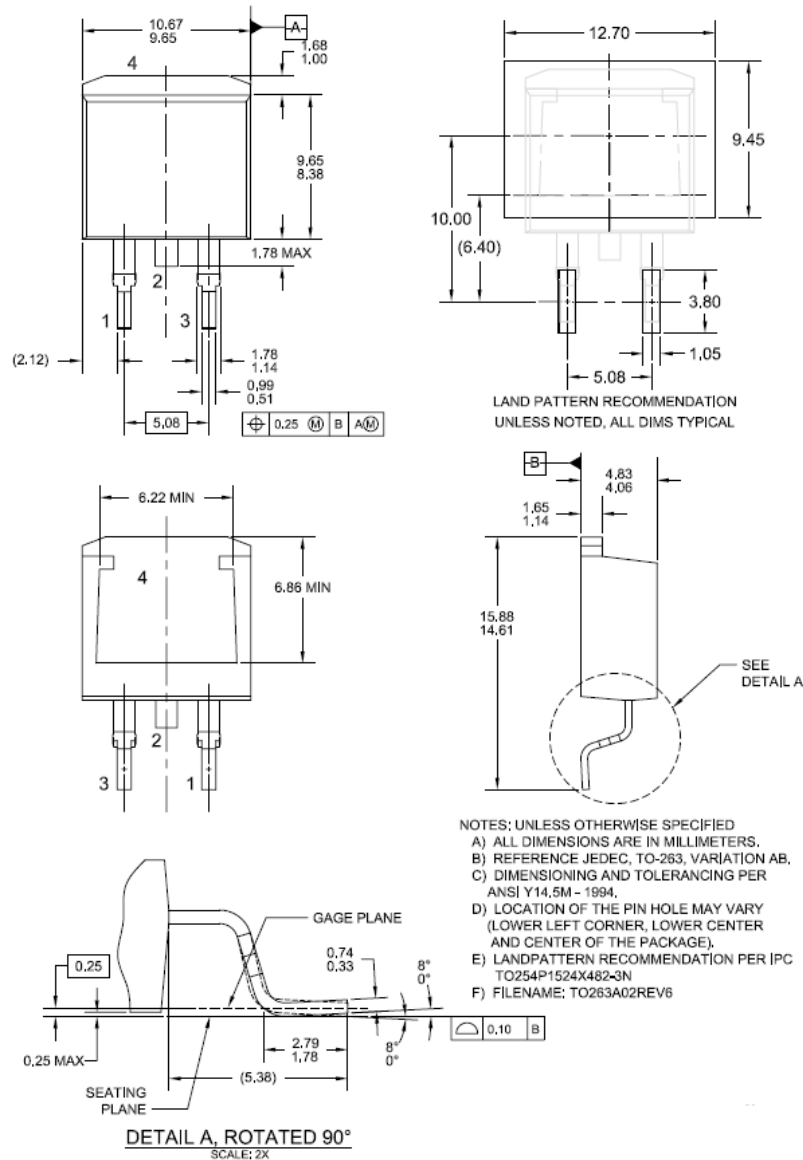


Figure 17. Transient Thermal Impedance of IGBT



## Mechanical Dimensions



**Figure 18. TO-263 2L (D2PAK) - 2LD, TO263, SURFACE MOUNT**

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Dimensions in Millimeters





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| FastvCore™  | OPTOLOGIC®                                     | SupreMOS®   | XS™   |
| FETBench™   | OPTOPLANAR®                                    | SyncFET™  | 仙童™   |
| FPS™  |  | Sync-Lock™  |   |

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